Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/626,596	SHEN ET AL.	
Examiner	Art Unit	
German Viana Di Prisco	2619	

SEARCHED				
Class	Subclass	Date	Examiner	
370	352	10/31/2007 ·	GV	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	1			
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST Image and keybpoard search in USPAT, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (see attached search strategy)	10/31/2007	GV
Inventor and Assignee search in PALM ExPO and EAST	10/31/2007	GV
EPO Database(http://ep.espacenet.com)	10/31/2007	GV
IEEE Xplore(http://ieeexplore.ieee.org/Xplor e/dynhome.jsp)	10/31/2007	GV
legal with intercept\$3 and sip and ip and rtp	10/31/2007	GV
Consulted with Ken Vanderpuye	10/31/2007	GV
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